

## Structure and Property Correlation in Bismuth Lithium Titanate: A Systematic Analysis

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**Abstract:** Bismuth lithium titanate ( $\text{BiLiTiO}_6$ ) is synthesized by the conventional solid-state reaction method to examine its structural and electrical behaviour. X-ray diffraction analysis confirms the formation of a single-phase orthorhombic structure, while SEM shows non-uniformly distributed grains over the surface of the pellet sample. Impedance spectroscopy is carried out over broad frequency span (100 Hz–1 MHz) and wide temperature range 30–500 °C. The results indicate that the dielectric and conductivity properties are strongly frequency and temperature-dependent. Activation energy estimated from AC conductivity plots followed Arrhenius behaviour, suggesting mixed-type conduction. The overall study of the compound highlights the correlation between structure and electrical response in bismuth lithium titanate. The impact of frequency and temperature on complex immittance parameters are analyzed by an impedance analyzer in broad frequencies and temperature ranges.

**Keywords:** X-Ray techniques, Complex-immittance, electrical conductivity, Ceramics, Complex immittance.

### 1. INTRODUCTION:

The miniaturization of modern electronic devices has a great demand for dielectric materials that offer enhanced performance while enabling compact component design. In multilayer ceramic capacitors, the use of multiple thin dielectric layers is common; however, this complexity can be reduced by employing materials that inherently possess high dielectric constants [1,2]. In this context, barium titanate ( $\text{BaTiO}_3$ , BT), a widely studied perovskite ferroelectric,

has remained a key material due to its large dielectric constant, tunable ferroelectric characteristics, and broad application in capacitors, sensors, memory devices, and other electronic components [3]. In general, high-permittivity dielectric materials are closely linked with ferroelectric or relaxor behaviour, and their dielectric response is strongly influenced by microstructural factors such as grain size [4–6]. Lead zirconate titanate ( $\text{Pb}(\text{Zr,Ti})\text{O}_3$ , PZT) has long been considered a benchmark material in piezoelectric applications because of its excellent electromechanical coupling, particularly near the morphotropic phase boundary (MPB) [7]. However, increasing concerns regarding the environmental and health risks associated with lead-based materials have accelerated the search for lead-free alternatives [8,9]. To address this need, several lead-free perovskite-based systems have been widely explored, including potassium sodium niobate ( $\text{K}_{0.5}\text{Na}_{0.5}\text{NbO}_3$ , KNN), sodium bismuth titanate ( $\text{Na}_{0.5}\text{Bi}_{0.5}\text{TiO}_3$ , NBT), and  $\text{BaTiO}_3$ -based ceramics [10–12]. Among these, NBT-based materials have gained significant attention due to their relatively high Curie temperature ( $\sim 380^\circ\text{C}$ ), favorable ferroelectric behaviour, and stable dielectric response. Despite these advantages, issues such as high coercive fields and structural complexity at room temperature still limit their practical use [13–15]. In order to overcome these limitations, various compositional modification strategies have been adopted, including solid-solution formation and aliovalent cation substitution, which can improve densification, lower coercive fields, and enhance piezoelectric/electromechanical performance [16–19]. Lithium substitution has been found to be particularly effective in tailoring ferroelectric behaviour. The incorporation of  $\text{Li}^+$  into Bi-based titanates not only provides charge compensation but also introduces structural distortion, which may improve dielectric properties [20]. As a result,  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT) has emerged as a promising lead-free ferroelectric material. Earlier studies suggest that BLT can stabilize structural phases, reduce coercive fields, and enhance the dielectric response of composite systems [21–23]. However, detailed understanding of its structural transitions and dielectric behaviour remains limited. Therefore, the present work focuses on the quantitative structural analysis and dielectric characterization of BLT ceramics synthesized via the conventional solid-state reaction route.

## **2. METHODOLOGY:**

### **2.1: Materials synthesis:**

Polycrystalline  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT) ceramic is prepared by the conventional solid-state reaction technique. High-purity analytical grade starting materials, namely  $\text{Bi}_2\text{O}_3$  (99.9%, Central Drug House Pvt. Ltd.),  $\text{TiO}_2$  (99.9%, Merck Specialities Pvt. Ltd.), and  $\text{Li}_2\text{CO}_3$  (99.9%, B.R.M. Enterprises Pvt. Ltd.), are weighed according to the desired stoichiometric composition. The powders are first mixed in air and thoroughly ground using an agate mortar and pestle. To achieve better homogeneity, the mixture is further wet-milled in methanol for 3 h and then dried. The dried powder is then calcined in air at 870 °C for 6 h. Intermediate heating is carried out from 650 °C in steps of 50 °C to facilitate the formation of the required perovskite phase. After calcination, a small amount of binder is added, and then the powder is pressed into pellets under a uniaxial pressure of  $4 \times 10^5 \text{ N/m}^2$ . The pellets are then sintered at 880 °C for 6 h to obtain dense ceramics. For electrical measurements, both faces of the sintered pellets are coated with highly conductive silver paste as electrodes. Finally, the samples are annealed at 150 °C for 2 h to remove residual moisture prior to dielectric and electrical characterization.

### **2.2: MATERIALS CHARACTERIZATION:**

The phase formation and quality of the synthesized  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT) compound are examined using X-ray diffraction (XRD). The XRD patterns are recorded with an X-ray powder diffractometer (Rigaku Miniflex) using  $\text{CuK}\alpha$  radiation ( $\lambda = 1.540 \text{ \AA}$ ). Data are collected over a range of Bragg angle  $2\theta = 20^\circ - 80^\circ$  at a scanning rate of  $3^\circ/\text{min}$ . The dielectric and impedance behaviour of the fired sample is evaluated using a HIOKI-3532-50 LCR Hi-tester. Measurements are performed in the frequency range of 100 Hz to 1 MHz and within a temperature window of 30 °C to 500 °C.

## **3. ANALYSIS OF RESULTS:**

### **3.1: Structural & microstructural analysis:**

Figure 1 gives the development of BLT compound which is characterized using the XRD data.

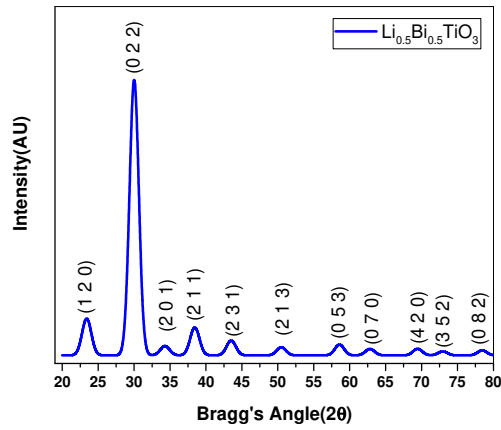


Figure 1. XRD patterns of  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT)

Table 1. Calculated and observed value of d-spacing and relative intensities

LBT					
$d_{\text{obs}}$	$d_{\text{cal}}$	H	K	L	$I/I_0$
3.7983	3.8004	1	2	0	45
2.9760	2.9780	0	2	2	100
2.6129	2.6151	2	0	1	38
2.3398	2.3337	2	2	1	25
2.0786	2.0835	2	3	1	30
1.8064	1.8068	2	1	3	22
1.5747	1.5747	0	5	3	18
1.4780	1.4775	0	7	0	15
1.3522	1.3522	4	2	0	10
1.2957	1.2957	3	5	2	8
1.2183	1.2184	0	8	2	5

Table 2. Cell parameters, volume, and crystallite size of the  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  compound

Compounds Name	Individual compound	a (Å)	b (Å)	c (Å)	Volume (Å <sup>3</sup> )	P (nm)
$\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$	BLT(x=0)	5.6037(29)	10.3428(29)	7.2852(29)	422.23	8.0266

The XRD pattern of  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT) confirms the formation of a single-phase compound without any impurity peaks [24]. All reflection peaks are indexed using POWD-MULT software [25], and the obtained diffraction peaks match well with the reported orthorhombic perovskite structure. Table 1 shows the comparison between the observed ( $d_{\text{obs}}$ ) and calculated ( $d_{\text{cal}}$ ) interplanar spacing values. The close agreement between these values confirms the reliability of the indexing, while the assignment of diffraction peaks to the corresponding (hkl) planes verifies the orthorhombic phase. The (0 2 2) reflection at  $\sim 32.5^\circ$  is identified as the most intense peak, normalized to 100% relative intensity. The absence of additional unindexed peaks further indicates the phase purity of the compound. The refined lattice parameters of the orthorhombic unit cell are obtained as  $a = 5.6037 \text{ \AA}$ ,  $b = 10.3428 \text{ \AA}$ , and  $c = 7.2852 \text{ \AA}$ , with a unit cell volume of  $422.23 \text{ \AA}^3$  (Table 2). The average crystallite size, calculated using the Scherrer equation from the (0 2 2) peak, is found to be  $\sim 8.02 \text{ nm}$ , confirming the nano-crystalline nature of the sample. Although some earlier reports have suggested both tetragonal and orthorhombic phases for BLT [26], the present diffraction pattern clearly supports the orthorhombic structure. This conclusion is in good agreement with the observed and calculated d-values, as well as with the peak splitting observed in the diffraction profile [27]. The average crystallite size of the BLT compound is estimated from XRD data using the peak broadening method and Scherrer's relation:

$$D = \frac{k\lambda}{\beta_{1/2} \cos \theta_{\text{Bragg}}}$$

where  $k = 0.89$  (shape factor),  $\lambda = 1.54 \text{ \AA}$  (CuK $\alpha$  radiation), and  $\beta_{1/2}$  is the full width at half maximum of the diffraction peak. The calculated crystallite size is  $8.0266 \times 10^{-9} \text{ m}$  ( $\approx 8 \text{ nm}$ ).

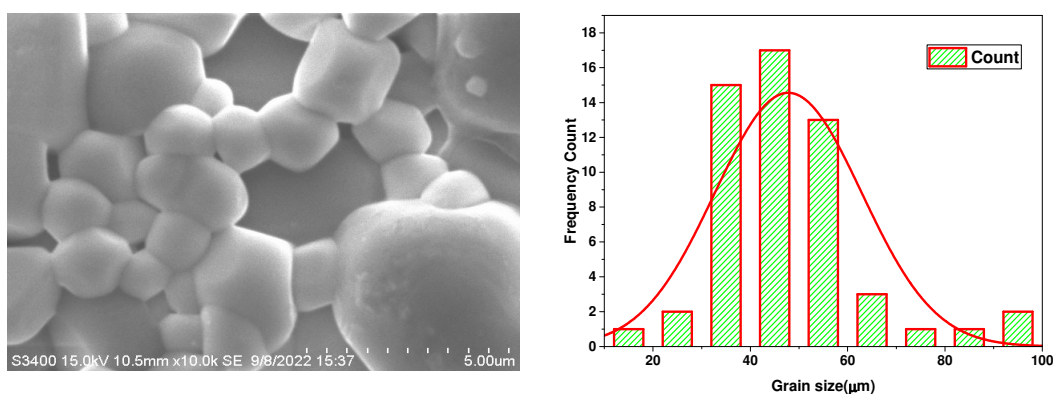


Figure 2. SEM image (left) and Histogram (right) of  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT)

Further insight into the microstructure is obtained through SEM analysis. The SEM micrograph (Figure 2, left) shows irregularly shaped grains with clear grain boundaries. The corresponding histogram (Figure 2, right) demonstrates a non-uniform distribution of grain of various sizes across the surface, with the average grain size estimated to be  $\approx 68.7 \mu\text{m}$ . These results confirm the nanoscale crystallite formation observed by XRD, while SEM reveals the growth and agglomeration of crystallites into larger grains at the microscale.

Figure 3, shows the EDX analysis which confirms the presence of major constituent elements—**bismuth, titanium, and oxygen**—with no detectable impurity peak, indicating the high purity of the synthesized sample. The corresponding elemental composition in terms of weight and atomic percentages is shown in the inset table. Although lithium is a constituent of BLT, it is not observed in the EDX spectrum. This absence is attributed to the **low atomic number of lithium**, which makes it difficult to detect using EDX due to its limited sensitivity to light elements.

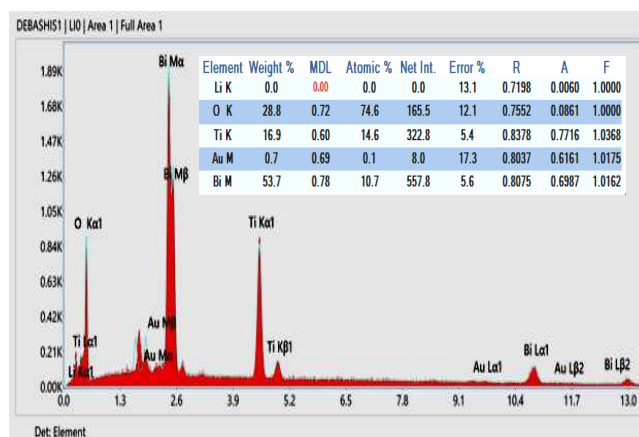
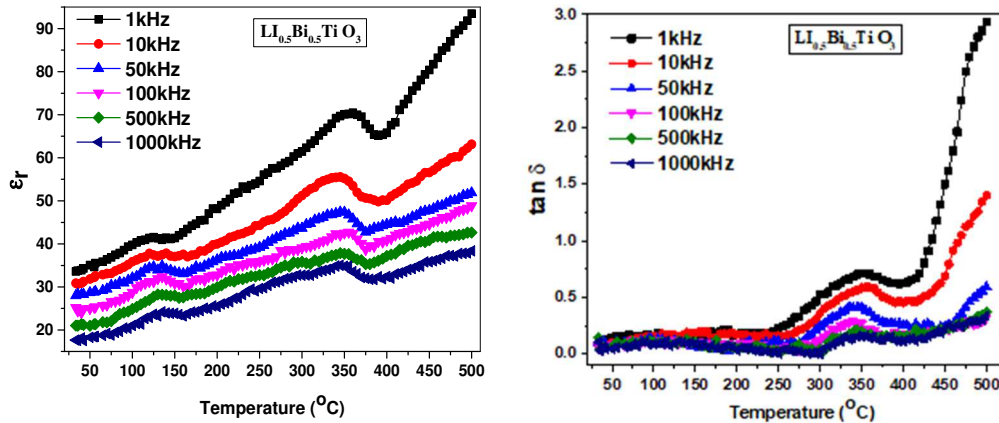


Figure 3. EDX of  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT).

### 3.2 Dielectric Study:

Figure 4 shows the variation of dielectric constant ( $\epsilon_r$ ) and loss tangent ( $\tan \delta$ ) with temperature at different frequencies for the BLT sample. Two dielectric anomalies are observed: the first at  $\sim 125^\circ\text{C}$ , which may correspond to a ferroelectric–antiferroelectric transition, and the second at  $\sim 350^\circ\text{C}$ , which can be attributed to the transition from antiferroelectric to paraelectric phase. Similar anomalies have been reported by other researchers in Bi-based titanates [28, 29].



**Figure 4.**  $\epsilon_r$ -Temperature and Loss  $\tan\delta$  vs temperature for BLT compound.

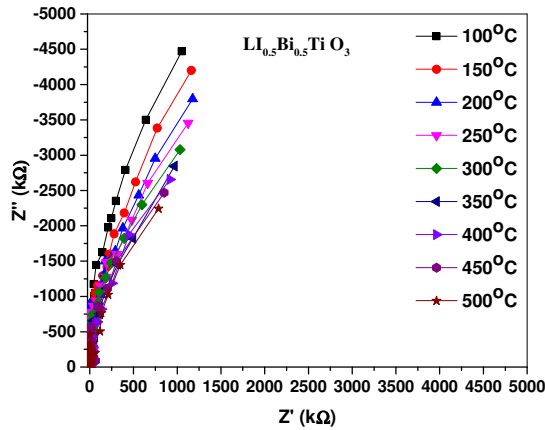
The dielectric constant ( $\epsilon_r$ ) decreases with increasing frequency, which is a common characteristic of polar dielectrics. At low frequencies, the high values of  $\epsilon_r$  arise due to contributions from space charge, dipolar, ionic, and electronic polarization mechanisms [30,31]. As frequency increases, these polarization contributions cannot keep up with the rapidly oscillating field, leading to a reduction in  $\epsilon_r$ . The dielectric loss ( $\tan \delta$ ) also exhibits temperature and frequency dependence. At lower temperatures,  $\tan \delta$  is very small, confirming that the material possesses good ferroelectric/insulating properties. With increasing temperature,  $\tan \delta$  increases due to the enhancement of ionic mobility and thermally activated conduction [32]. Peaks in  $\tan \delta$  are observed close to the dielectric anomalies (125 °C and 350 °C), indicating the presence of relaxation processes. These relaxations are particularly pronounced at lower frequencies, which are attributed to grain boundary effects and contributions from dc conductivity [33].

Thus, the dielectric study confirms two distinct phase transitions in BLT and highlights its low dielectric loss in the low-temperature regime, suggesting potential applications in ferroelectric devices.

### 3.3 Impedance analysis:

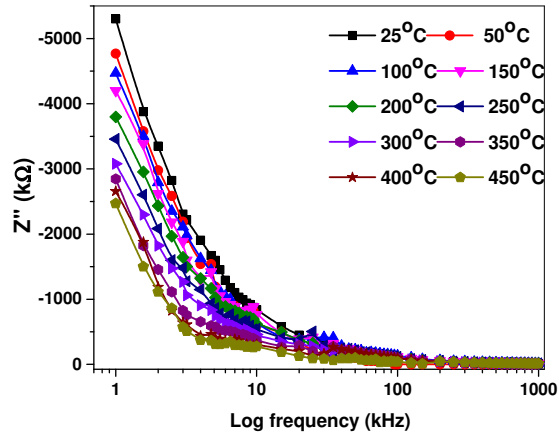
Complex immittance spectroscopy (CIS) is considered as the most reliable technique for understanding the electrical behaviour of materials in which multiple processes contribute simultaneously. It is particularly useful for distinguishing the contribution of the bulk (intra-grain) response from that of the bulk–interface or grain-boundary (inter-grain) effects in the overall transport properties of the system.

The complex impedance ( $Z'-Z''$ ) plots of BLT at selected temperatures are presented in Figure 5 for both low and high temperature regions. In all temperature ranges, the impedance spectra exhibit a single semi-circular arc, indicating that the electrical response is mainly governed by bulk processes within the material. This behaviour can be represented by an equivalent parallel RC circuit. Furthermore, the decrease in resistivity with increasing temperature is evident from the shift of the arc intercepts towards the origin along the real axis. The observed reduction in resistance confirms enhanced bulk conduction at higher temperatures [13].

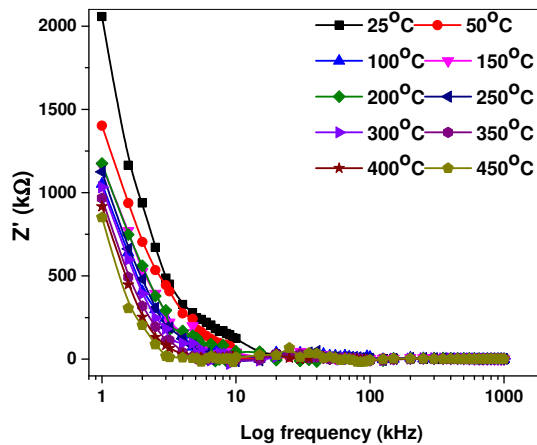


**Figure 5. Nyquist plots of  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  compound at different temperatures**

The loss spectra, i.e., the frequency dependence of  $Z''$  for  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  at different temperatures, are presented in Figure 6(a). At low frequencies, the dispersion observed for all temperatures indicates the involvement of space-charge carriers such as ions, vacancies, and electrons. With increasing frequency, the  $Z''$  values gradually decrease and tend to merge in the high-frequency region, showing a nearly frequency- and temperature-independent behaviour. This merging of the curves at higher frequencies can be attributed to the release of space charges.



(a)



(b)

**Figure 6. Frequency-dependent  $Z''$  (a) and  $Z'$  (b) graphs of  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  compound at different temperatures**

The  $Z'$ -frequency plots recorded at different temperatures (25–500 °C) are presented in Figure 6(b). At low frequencies, a spike-like response is observed for almost all temperatures, while with increasing temperature the dispersion becomes more prominent in the high-frequency region. It is also noted that the magnitude of  $Z'$  decreases with rising temperature, indicating NTCR behaviour. Moreover,  $Z'$  shows a significant increase at both low- and high-temperature regions.

### 3.4 Conductivity study:

The ac conductivity ( $\sigma_{ac}$ ) of the BLT sample was calculated using the relation [34]  $\sigma_{ac} = \epsilon_0 \epsilon_r \omega \tan \delta$  where  $\epsilon_0$  is the permittivity of free space,  $\epsilon_r$  is the dielectric constant,  $\omega$  is the angular frequency, and  $\tan \delta$  is the loss tangent.

Figure 7, illustrates the variation of  $\sigma_{ac}$  with inverse absolute temperature ( $1000/T$ ) at different frequencies. It is observed that  $\sigma_{ac}$  increases with temperature, demonstrating negative temperature coefficient of resistance (NTCR) behavior, which is typical of semiconducting oxides. The conductivity response is divided into three distinct regions. In region-I conductivity is nearly temperature independent, suggesting localized hopping of charge carriers, in region-II conductivity increases rapidly with temperature, indicating a thermally activated process, and in region-III conductivity again shows weaker temperature dependence, implying saturation of carrier mobility.

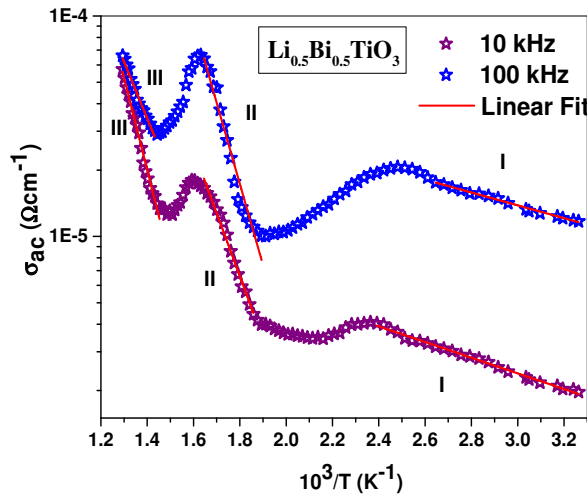


Figure 7. Variation of ac conductivity with the temperature of BLT compound.

Table 3. Value of activation energies in different frequency regions

Compounds name	Individual Compound	Frequencies	Activation energy $E_a$ (eV)		
			Region-I	Region-II	Region-III
$Li_{0.5}Bi_{0.5}TiO_3$	LBT(x=0)	10 kHz	0.07054	0.56629	0.82848
		100 kHz	0,04008	0.72965	0.50915

The activation energy ( $E_a$ ) is evaluated using the Arrhenius relation  $\sigma_{ac} = \sigma_0 \exp(-E_a/kBT)$ . The calculated  $E_a$  values (Table 3) vary with frequency and temperature, indicating different conduction mechanisms in different regions. Lower  $E_a$  at low temperatures suggests excitation of localized charge carriers, whereas higher  $E_a$  at elevated temperatures is attributed to long-range ionic migration and grain-boundary conduction. The merging of  $\sigma_{ac}$  plots at high temperatures into a master curve indicates frequency-independent conduction in this region.

#### 4. CONCLUSIONS:

Polycrystalline  $\text{Bi}_{0.5}\text{Li}_{0.5}\text{TiO}_3$  (BLT) ceramics is successfully synthesized by the solid-state reaction route. XRD confirms a single-phase orthorhombic perovskite structure with nanoscale crystallite size, while SEM/EDX shows irregular grains size, non-uniform distribution, and no impurity phases. Dielectric studies revealed anomalies near 125 °C and 350°C, associated with ferroelectric–antiferroelectric and antiferroelectric–paraelectric transitions. The dielectric constant shows strong frequency dispersion with low loss at low temperatures. AC conductivity follows Arrhenius behaviour and Jonscher's power law, indicating multiple conduction mechanisms with NTCR behaviour. The  $Z'-Z''$  plots exhibit single semicircular arcs, suggesting dominant bulk contribution. In overall, BLT exhibits potential application for lead-free electronic devices such as thermistors, capacitors, sensors, and energy-storage devices.

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